

Notice of References Cited	Application/Control No. 10/566,997		Applicant(s)/Patent Under Reexamination HECKMEIER ET AL.	
	Examiner Shean C. Wu		Art Unit 1756	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0040365	02-2005	Heckmeier et al.	252/299.63
*	B	US-7,175,891	02-2007	Heckmeier et al.	428/1.3
*	C	US-7,105,210	09-2006	Heckmeier et al.	428/1.1
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*	E	US-5,961,881	10-1999	Andou et al.	252/299.63
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*	G	US-6,497,929	12-2002	Miyairi et al.	428/1.1
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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